

# Search Notes



Application/Control No.

10/071,452

Examiner

DANH C. LE

Applicant(s)/Patent under Reexamination

BURKE ET AL.

Art Unit

2683

## SEARCHED

Class	Subclass	Date	Examiner
455	272	10/27/05	DCL
	70		
	276.1		
370	337		
	524		
375	148		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search		10/28/05	DCL

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor Name Search (for double patent check)	10/27/05	DCL
Lee Nguyen (455)		
Vuong Hien (455)		
FAST Search updated (USP, US PUB, EPO, JPO, DERWENT)	10/28/05	DCL